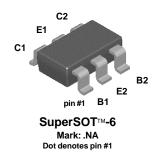


FMB100



NPN Multi-Chip General Purpose Amplifier

This device is designed for general purpose amplifier applications at collector currents to 300 mA. Sourced from Process 10.

Absolute Maximum Ratings* T_A =25°C unless otherwise noted

Symbol	Parameter	Value	Units
V _{CEO}	Collector-Emitter Voltage	45	V
V _{CBO}	Collector-Base Voltage	75	V
V _{EBO}	Emitter-Base Voltage	6.0	V
Ic	Collector Current - Continuous	500	mA
T _J , T _{stg}	Operating and Storage Junction Temperature Range	-55 to +150	°C

^{*}These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

These ratings are based on a maximum junction temperature of 150 degrees C.
 These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

Symbol	Characteristic	Max	Units
		FMB100	
P _D	Total Device Dissipation	700	mW
	Derate above 25°C	5.6	mW/°C
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	180	°C/W

NPN Multi-Chip General Purpose Amplifier

(continued)

Min Typ Max Units

F	lect	rical	∣ Ch	ara	cte	rist	tics
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Parameter

Symbol

T_A= 25°C unless otherwise noted

Test Conditions

BV _{CBO}	Collector-Base Breakdown Voltage	$I_C = 10 \mu A, I_B = 0$	75		V
BV _{CEO}	Collector-Emitter Breakdown Voltage*	$I_C = 1 \text{ mA}, I_E = 0$	45		V
BV _{EBO}	Emitter-Base Breakdown Voltage	$I_E = 10 \mu\text{A}, I_C = 0$	6.0		V
Ісво	Collector Cutoff Current	V _{CB} = 60 V		50	nA
I _{CES}	Collector Cutoff Current	V _{CE} = 40 V		50	nA
I _{EBO}	Emitter Cutoff Current	V _{EB} = 4 V		50	nΑ

ON CHARACTERISTICS

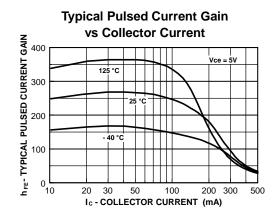
h _{FE}	DC Current Gain	I _C = 100 µA, V _{CE} = 1.0 V I _C = 10 mA, V _{CE} = 1.0 V I _C = 100 mA, V _{CE} = 1.0 V* I _C = 150 mA, V _{CE} = 5.0 V*	80 100 100 100	450 350	
V _{CE(sat)}	Collector-Emitter Saturation Voltage	I _C = 10 mA, I _B = 1.0 mA I _C = 200 mA, I _B = 20 mA*		0.2 0.4	V
V _{BE(sat)}	Base-Emitter Saturation Voltage	$I_C = 10 \text{ mA}, I_B = 1.0 \text{ mA}$ $I_C = 200 \text{ mA}, I_B = 20 \text{ mA}^*$		0.85 1.0	V V

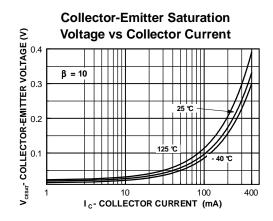
SMALL SIGNAL CHARACTERISTICS

f _T	Current Gain - Bandwidth Product	$V_{CE} = 20 \text{ V}, I_{C} = 20 \text{ mA}$	300	MHz
C _{obo}	Output Capacitance	V _{CB} = 5.0 V, f = 1.0 MHz	3.5	pF
NF	Noise Figure	I_C = 100 μA, V_{CE} = 5.0 V, R_G = 2.0 kΩ, f = 1.0 kHz	2.5	dB

^{*}Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2.0%

Typical Characteristics

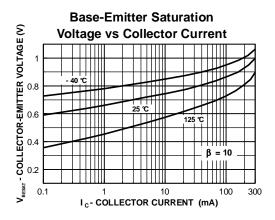


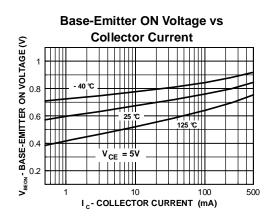


NPN Multi-Chip General Purpose Amplifier

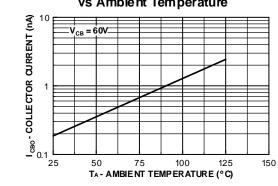
(continued)

Typical Characteristics (continued)

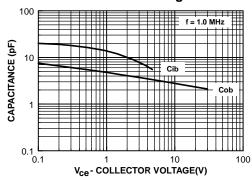




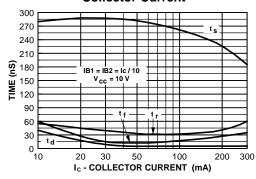
Collector-Cutoff Current vs Ambient Temperature



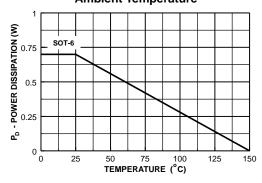
Input and Output Capacitance vs Reverse Voltage



Switching Times vs Collector Current



Power Dissipation vs Ambient Temperature



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PRODUCT STATUS DEFINITIONS

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No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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